

Dual P-Channel Enhancement Mode Power MOSFET

DESCRIPTION

The HM4953B uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

• $V_{DS} = -20V, I_{D} = -5A$

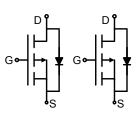
 $R_{DS(ON)} < 110 m\Omega @ V_{GS} = -4.5 V$

 $R_{DS(ON)}$ < 60m Ω @ V_{GS} =-10V

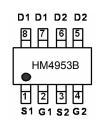
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- PWM applications
- Load switch
- Power management



Schematic diagram



Marking and pin Assignment



SOP-8 top view

Package Marking And Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HM4953B	HM4953B	SOP-8	Ø180mm	8 mm	3000 units

Absolute Maximum Ratings (TA=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	-20	V
Gate-Source Voltage	V _G S	±10	V
Drain Current-Continuous	I _D	-5	Α
Drain Current -Pulsed (Note 1)	I _{DM}	-20	Α
Maximum Power Dissipation	P _D	1	W
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55 To 150	$^{\circ}$

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)			R _{θJA}	125	°C/W
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Electrical Characteristics (TA=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-20	-24	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-20V,V _{GS} =0V	-	-	-1	μA

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Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm10V, V_{DS}=0V$	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$ $V_{DS}=V_{GS},I_D=-250\mu A$		-0.4	-0.7	-1	V
Drain-Source On-State Resistance	D	V _{GS} =-4.5V, I _D =-4A	-	64	110	mΩ
Dialii-Source Oil-State Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-5A	-	55	60	mΩ
Forward Transconductance	g FS	V _{DS} =-5V,I _D =-2.8A	-	9.5	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	\/ - 10\/\/ -0\/	-	405	-	PF
Output Capacitance	Coss	V_{DS} =-10V, V_{GS} =0V, F=1.0MHz	-	75	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.UIVIFIZ	-	55	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	11	-	nS
Turn-on Rise Time	t _r	V _{DD} =-10V,I _D =-1A	-	35	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =-4.5V, R_{GEN} =10 Ω	-	30	-	nS
Turn-Off Fall Time	t _f		-	10	-	nS
Total Gate Charge	Q_g	\/ - 40\/ - 24	-	3.3	12	nC
Gate-Source Charge	Q_gs	V_{DS} =-10V, I_{D} =-3A, V_{GS} =-2.5V	-	0.7	-	nC
Gate-Drain Charge	Q_{gd}	VGS2.5V	-	1.3	-	nC
Drain-Source Diode Characteristics	•					
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =1.3A	-	-	-1.2	V
Diode Forward Current (Note 2)	Is		-	-	-1.3	Α

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤ 300μ s, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

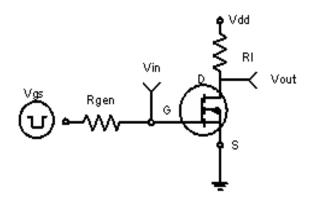
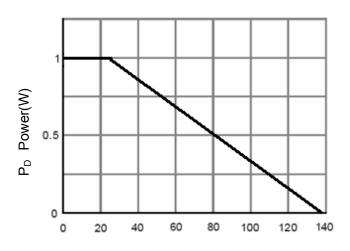


Figure 1:Switching Test Circuit



 T_J -Junction Temperature (°C) Figure 3 Power Dissipation

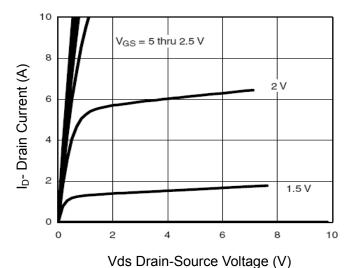


Figure 5 Output CHARACTERISTICS

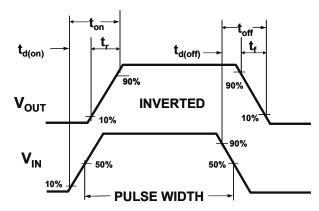


Figure 2:Switching Waveforms

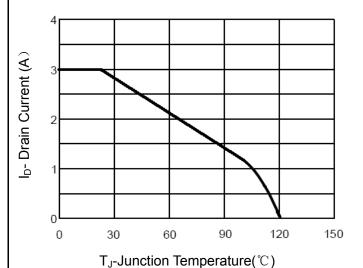


Figure 4 Drain Current

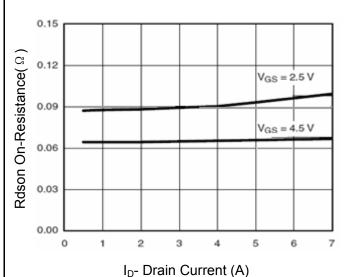
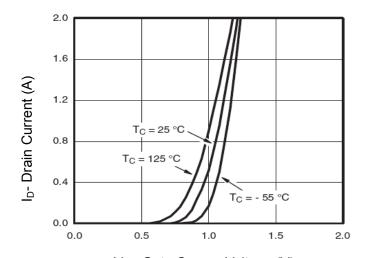


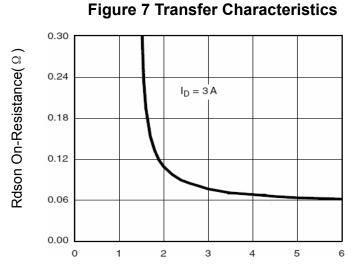
Figure 6 Drain-Source On-Resistance

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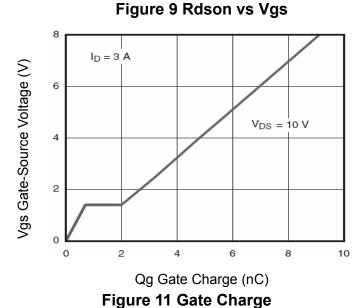
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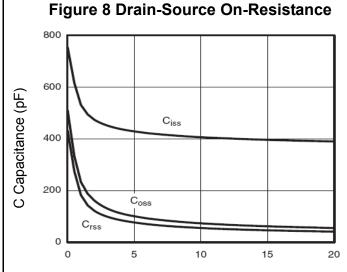
Vgs Gate-Source Voltage (V)



Vgs Gate-Source Voltage (V)



T_J-Junction Temperature(°C)



Vds Drain-Source Voltage (V)

Figure 10 Capacitance vs Vds

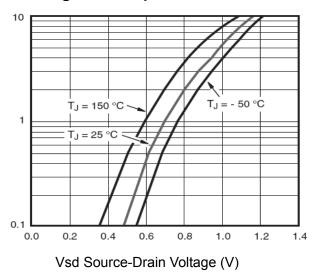
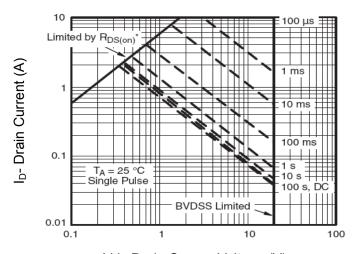


Figure 12 Source- Drain Diode Forward

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Is- Reverse Drain Current (A)

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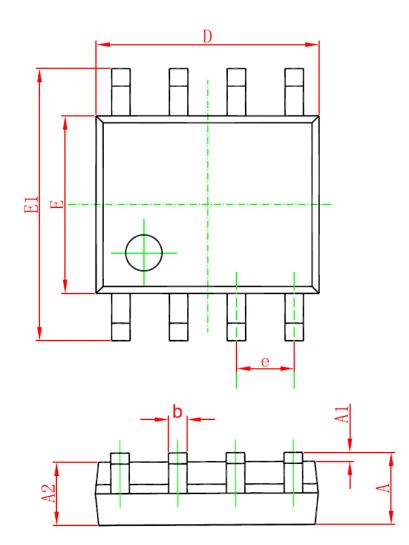


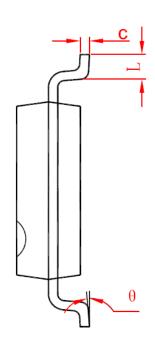
Vds Drain-Source Voltage (V)

Figure 13 **Safe Operation Area** 10⁰ Transient Thermal Impedance r(t), Normalized Effective 10⁻¹ 10⁻² Reja (t)=r(t) * Reja Reja=See Datasheet Tjm-Ta = P* Reja (t) 4. Duty Cycle, D=t1/t2 10⁻⁴ 10⁻² 10⁻³ 10⁻¹ 10⁰ 10¹ 10² Square Wave Pluse Duration(sec)

Figure 14 Normalized Maximum Transient Thermal Impedance

SOP8 PACKAGE OUTLINE DIMENSIONS





C.mhal	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1. 350	1. 750	0. 053	0.069	
A1	0. 100	0. 250	0. 004	0. 010	
A2	1. 350	1. 550	0. 053	0. 061	
b	0. 330	0. 510	0. 013	0. 020	
С	0. 170	0. 250	0. 006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
E	3.800	4. 000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0. 050 (BSC)		
L	0.400	1. 270	0. 016	0.050	
θ	0°	8°	0°	8°	

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